

MOS FIELD EFFECT TRANSISTOR 2SK2983

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK2983 is N-Channel MOS Field Effect Transistor designed for high current switching application.

FEATURES

- Low on-resistance
 $R_{DS(on)1} = 20 \text{ m}\Omega \text{ MAX. (} V_{GS} = 10 \text{ V, } I_D = 15 \text{ A)}$
 $R_{DS(on)2} = 27 \text{ m}\Omega \text{ MAX. (} V_{GS} = 4.5 \text{ V, } I_D = 15 \text{ A)}$
- Low C_{iss} $C_{iss} = 1300 \text{ pF TYP.}$
- Built-in gate protection diode

ORDERING INFORMATION

PART NUMBER	PACKAGE
2SK2983	TO-220AB
2SK2983-S	TO-262
2SK2983-ZJ	TO-263

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$)

Drain to Source Voltage ^{Note 1}	V_{DSS}	30	V
Gate to Source Voltage ^{Note 2}	V_{GSS}	± 20	V
Drain Current (DC)	$I_{D(DC)}$	± 30	A
Drain Current (pulse) ^{Note 3}	$I_{D(pulse)}$	± 120	A
Total Power Dissipation ($T_A = 25^\circ\text{C}$)	P_T	1.5	W
Total Power Dissipation ($T_C = 25^\circ\text{C}$)	P_T	50	W
Channel Temperature	T_{ch}	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 to +150	$^\circ\text{C}$

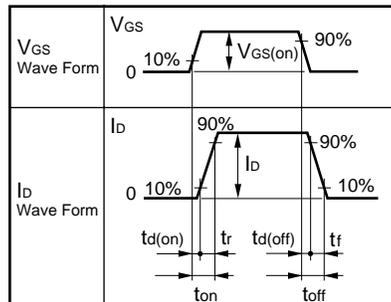
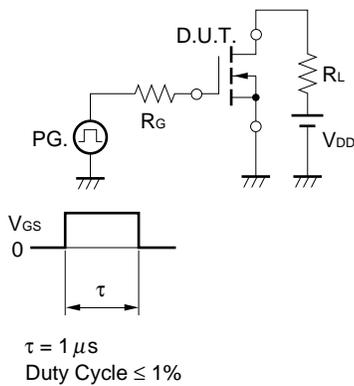
- Notes**
1. $V_{GS} = 0 \text{ V}$
 2. $V_{DS} = 0 \text{ V}$
 3. $PW \leq 10 \mu\text{s}$, Duty Cycle $\leq 1\%$

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 Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

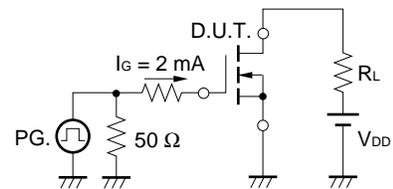
ELECTRICAL CHARACTERISTICS (T_A = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	R _{DS(on)1}	V _{GS} = 10 V, I _D = 15 A		13.0	20.0	mΩ
	R _{DS(on)2}	V _{GS} = 4.5 V, I _D = 15 A		18.0	27.0	mΩ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.0	1.5	2.0	V
Forward Transfer Admittance	y _{fs}	V _{DS} = 10 V, I _D = 15 A	9.0	19		S
Drain Leakage Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			10	μA
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ±20 V, V _{DS} = 0 V			±10	μA
Input Capacitance	C _{iss}	V _{DS} = 10 V		1300		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V		530		pF
Reverse Transfer Capacitance	C _{rss}	f = 1 MHz		250		pF
Turn-on Delay Time	t _{d(on)}	I _D = 15 A		50		ns
Rise Time	t _r	V _{GS(on)} = 10 V		820		ns
Turn-off Delay Time	t _{d(off)}	V _{DD} = 15 V		100		ns
Fall Time	t _f	R _G = 10 Ω		170		ns
Total Gate Charge	Q _G	I _D = 30 A		30		nC
Gate to Source Charge	Q _{GS}	V _{DD} = 24 V		4.5		nC
Gate to Drain Charge	Q _{GD}	V _{GS} = 10 V		7.5		nC
Body Diode Forward Voltage	V _{F(S-D)}	I _F = 30 A, V _{GS} = 0 V		0.8		V
Reverse Recovery Time	t _{rr}	I _F = 30 A, V _{GS} = 0 V		35		ns
Reverse Recovery Charge	Q _{rr}	di/dt = 100 A / μs		65		nC

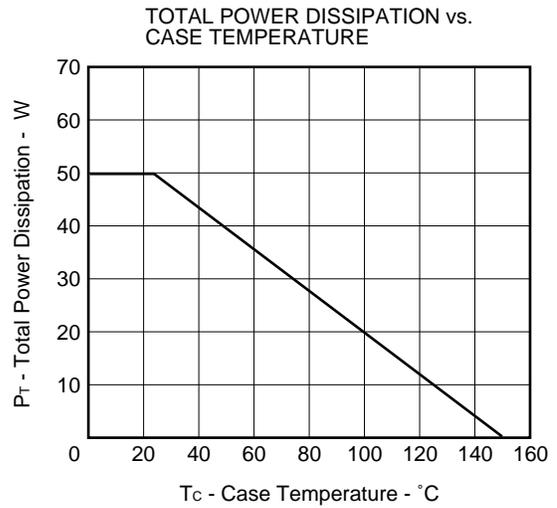
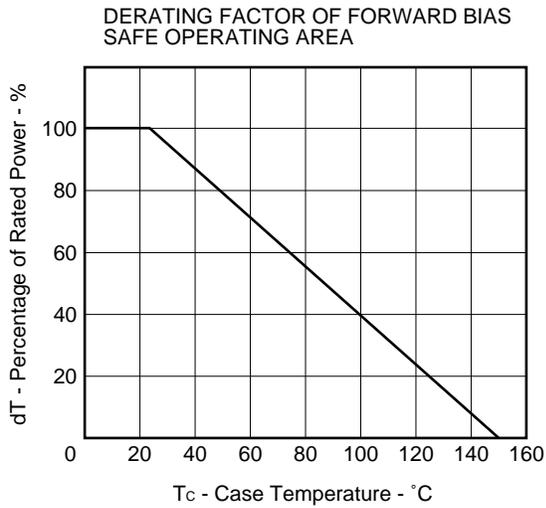
TEST CIRCUIT 1 SWITCHING TIME



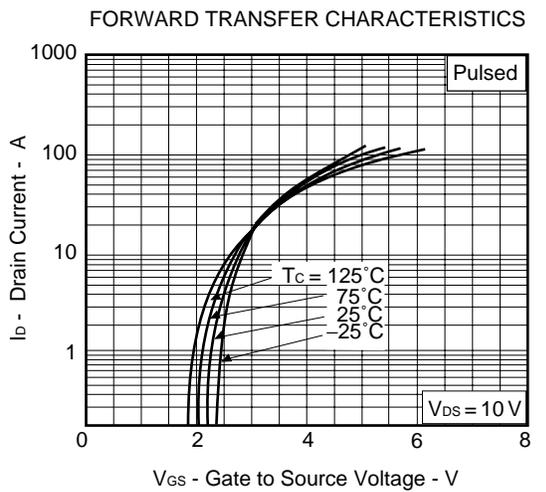
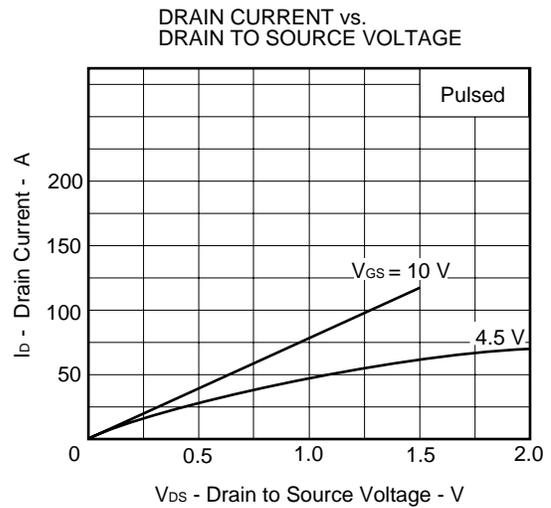
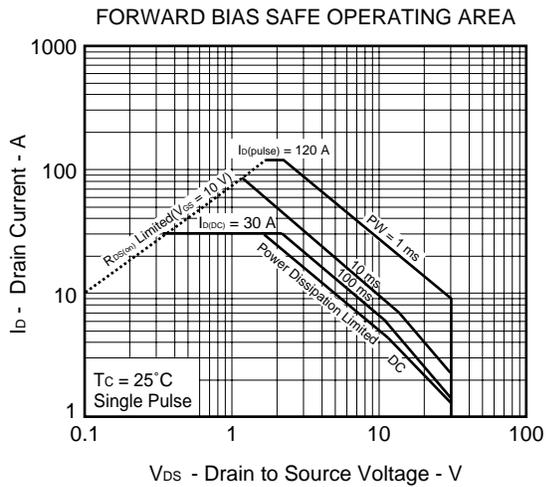
TEST CIRCUIT 2 GATE CHARGE



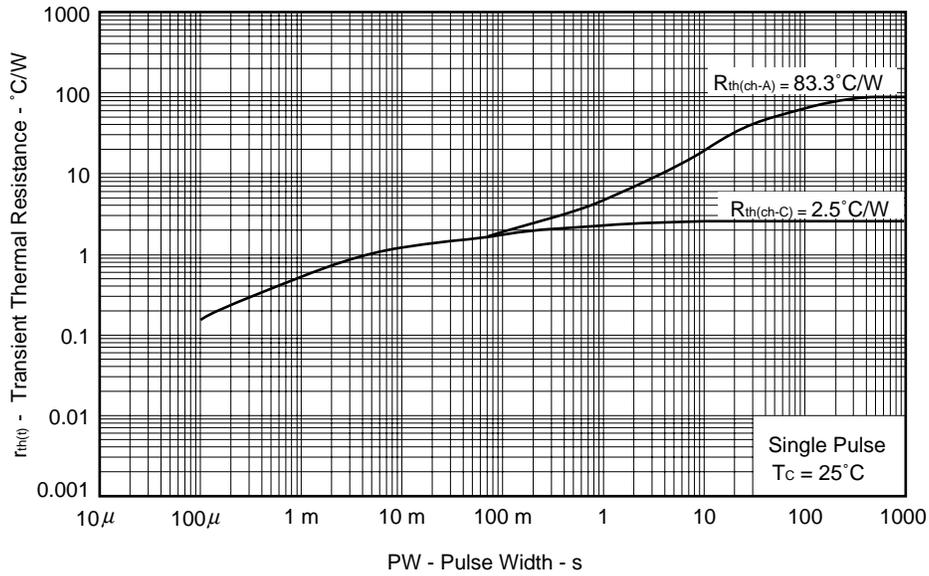
TYPICAL CHARACTERISTICS (T_A = 25 °C)



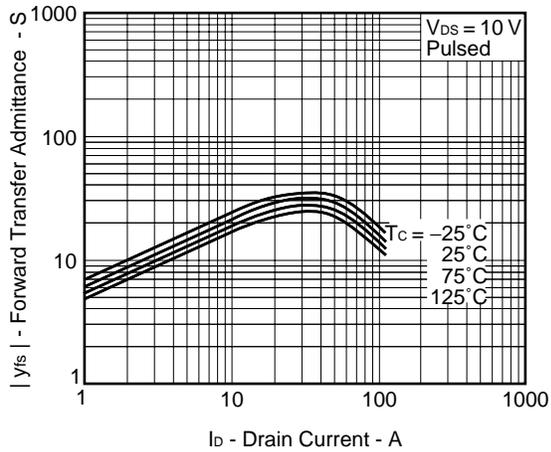
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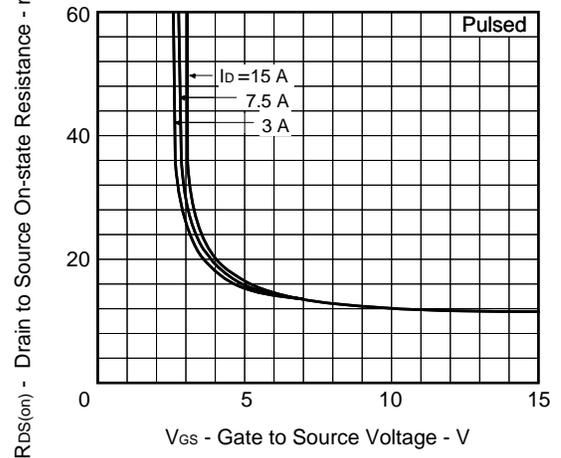
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



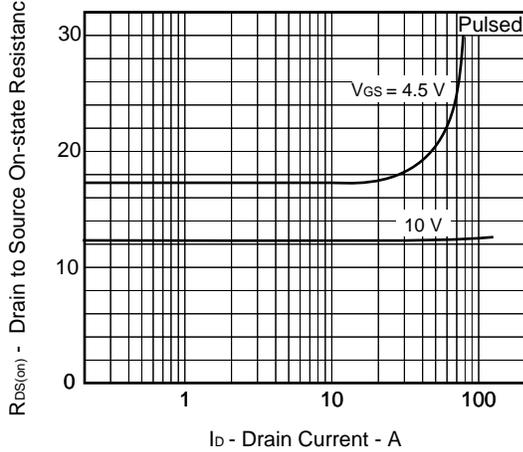
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



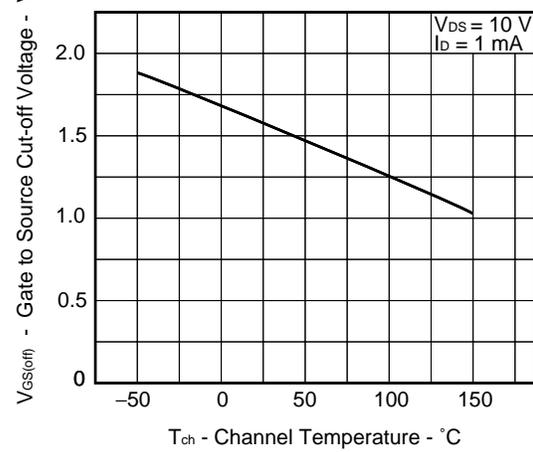
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

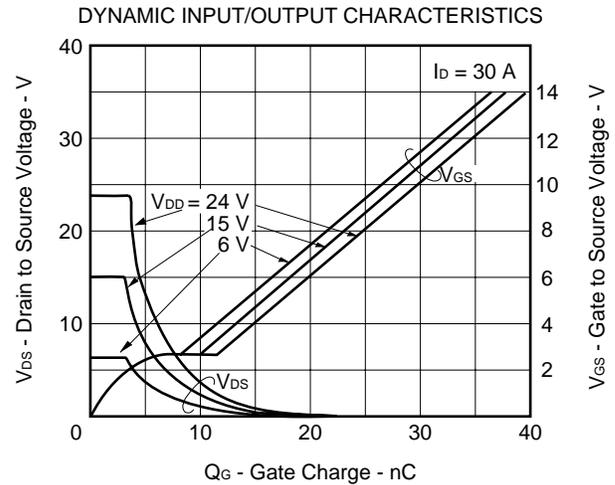
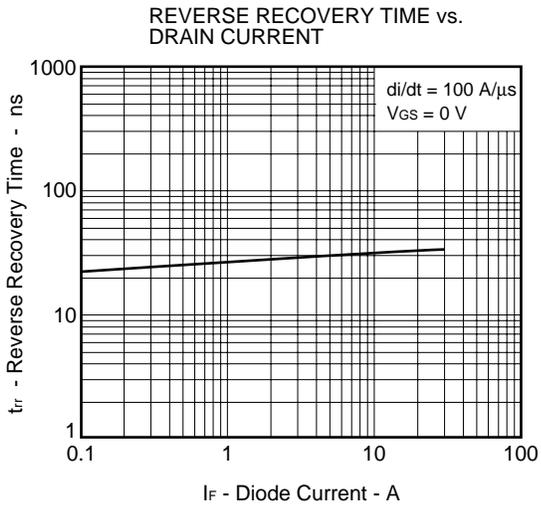
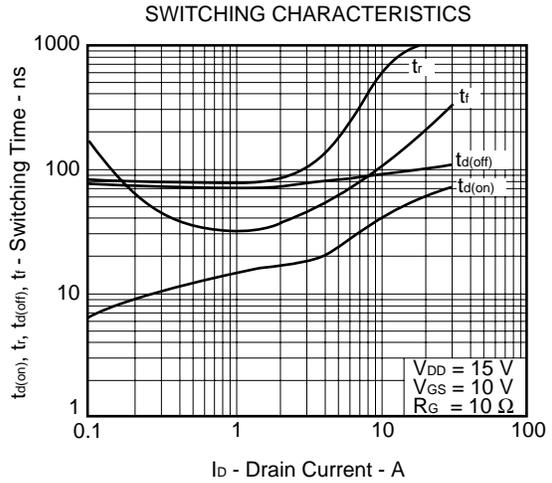
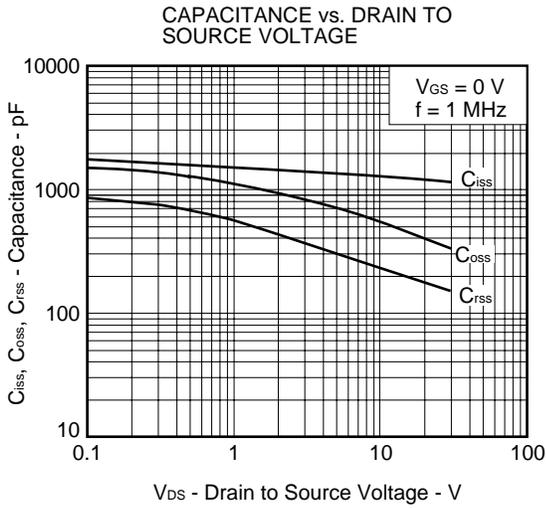
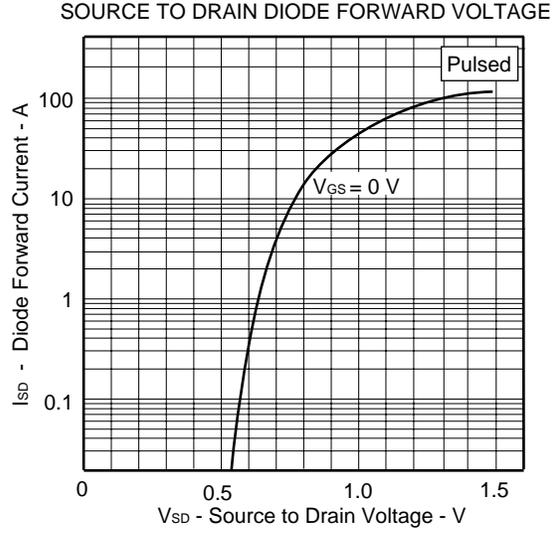
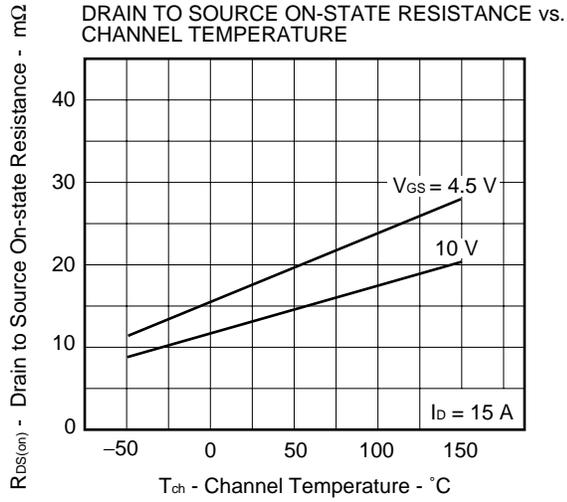


DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



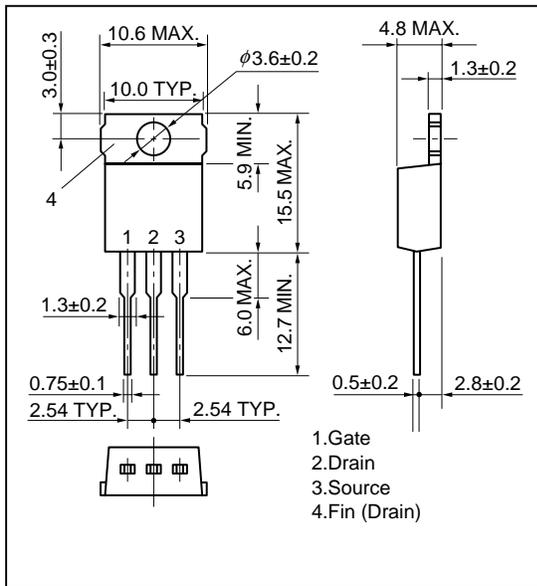
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



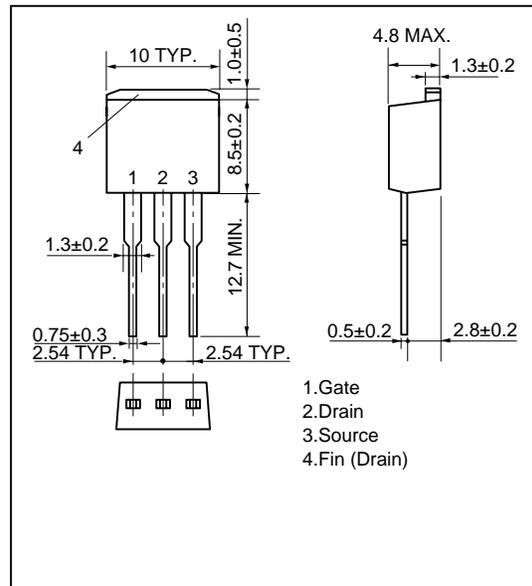


★ PACKAGE DRAWINGS (Unit: mm)

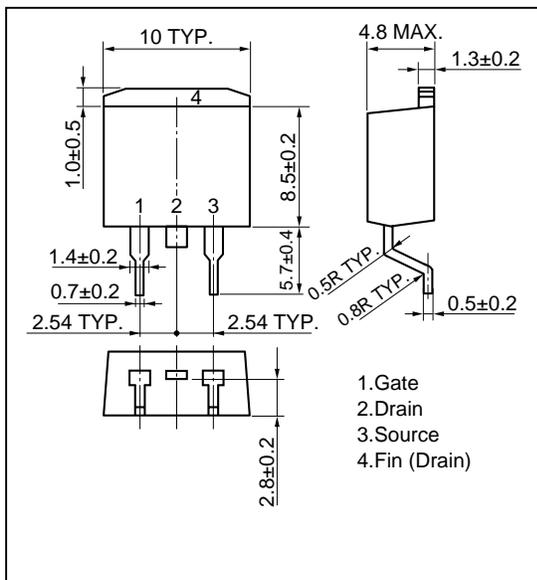
1) TO-220AB (MP-25)



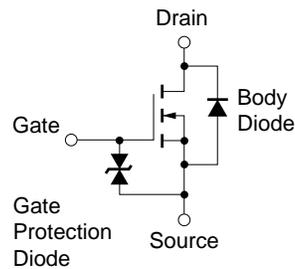
2) TO-262 (MP-25 Fin Cut)



3) TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device

[MEMO]

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